

ELECTRICAL CONNECTIONS WITHIN SUBSTRATES

TECHNICAL FIELD

[0001] The present invention relates generally to the field of electronics and, in particular, to electrical connections in substrates.

BACKGROUND

[0002] Situations frequently arise when electronic components, such as capacitors, integrated circuits, diodes, inductors, or the like, disposed on opposite sides of a substrate, such as a circuit board, microchip, or the like, are electrically interconnected by a conductor, such as a via, disposed within the substrate. The via usually passes through one or more electrically conductive planes disposed within the substrate and makes direct contact with the electrically conductive planes so that the via and electrically conductive planes are electrically connected.

[0003] One example involves a method for reducing a noise voltage on an output impedance of a power source used to power an integrated circuit (IC). The noise voltage is usually the result of a high-frequency current caused by behavior of the IC that gets passed from the IC to the power source. The noise voltage normally gets superimposed on voltages supplied by the power source to the IC. This adversely affects the performance of the IC.

[0004] The method reduces this noise by reducing the output impedance by directing the high-frequency current to ground through a capacitor connected in close proximity to the IC rather than allowing the high-frequency current to pass to the power source. In one implementation of this method, the capacitor and IC are located on opposite sides of a circuit board, and power and ground connections of the IC are connected to the capacitor using vias that pass through the circuit board. The vias connected to the ground and power connections are normally respectively connected to conductive ground and power planes disposed within the circuit board between the IC and capacitor.

[0005] It is known to those skilled in the art that high-frequency current flows substantially on the surface of a conductor and does not penetrate substantially into the interior of the conductor. Therefore, when high-frequency current flows from an electronic component on one side of a substrate, such as the IC in the above example, to an electronic component on an opposite side of the substrate, such as the capacitor in the above example, the high-frequency current flows substantially on the surface of the via. However, when the high-frequency current encounters the location where the via is connected to a conductive plane, such as the power plane in the above example, the high-frequency current changes its course so that the high-frequency current flows substantially on a surface of the plane. This is because the direct contact between the via and the plane at this location forms a solid boundary between the via and the plane that the high-frequency current cannot flow through. Therefore, the high-frequency current is forced to change its course a number of times to flow around the conductive plane and back to the via. This occurs each time the high-frequency current encounters a location where the via is connected to a conductive plane and thus causes the high-frequency current to follow an elongated, meandering path as it flows between the electronic components. One problem with this is the elongated, meandering path presents an inductance between the electronic components, and a noise voltage gets produced on impedance of the inductance as the high-frequency current flows between the electronic components.

[0006] For the reasons stated above, and for other reasons stated below that will become apparent to those skilled in the art upon reading and understanding the present specification, there is a need in the art for reducing the impedance between electronic components disposed on opposite sides of a substrate that are electrically interconnected by a conductor passing through one or more electrically conductive planes disposed within the substrate.

SUMMARY

[0007] The above-mentioned problems with impedance between electronic components disposed on opposite sides of a substrate that are electrically interconnected

by a conductor passing through one or more electrically conductive planes disposed within the substrate and other problems are addressed by embodiments of the present invention and will be understood by reading and studying the following specification.

[0008] In one embodiment, a substrate having a conductive plane and a via passing through the conductive plane is provided. The conductive plane contacts the via to electrically interconnect the via and the conductive plane. A gap in the conductive plane separates a surface of the via from the conductive plane to provide an uninterrupted path for electrical current flowing substantially on the surface of the via.

[0009] Further embodiments of the invention include methods and apparatus of varying scope.

BRIEF DESCRIPTION OF THE DRAWINGS

[0010] Figure 1 illustrates an electronic device according to the teachings of the present invention.

[0011] Figure 2 is a perspective view illustrating a connection of a via to a plane according to an embodiment of the present invention.

[0012] Figure 3 is a top view of Figure 2.

[0013] Figure 4 is a perspective view illustrating a connection of a via to more than one plane according to another embodiment of the present invention.

DETAILED DESCRIPTION

[0014] In the following detailed description, reference is made to the accompanying drawings that form a part hereof, and in which is shown by way of illustration specific illustrative embodiments in which the invention may be practiced. These embodiments are described in sufficient detail to enable those skilled in the art to practice the invention, and it is to be understood that other embodiments may be utilized and that logical, mechanical and electrical changes may be made without departing from the spirit and scope of the present invention. The following detailed description is, therefore, not to be taken in a limiting sense.

[0015] Embodiments of the present invention provide for a high-frequency current flowing substantially on a surface of a via to flow through a gap separating the via from a conductive plane through which the via passes. This reduces inductance and thus impedance and noise as compared to when a high-frequency current flowing substantially on a surface of a via changes its course and flows substantially on a surface of a conductive plane to flow around the plane.

[0016] Figure 1 illustrates an electronic device 100 according to an embodiment of the present invention. Electronic device 100 includes a substrate 101, such as a circuit board, microchip, or the like. Electronic components 102 and 104, such as capacitors, integrated circuits, diodes, inductors, or the like, are respectively disposed on side 106 and opposite side 108 of substrate 101. Vias 110₁ and 110₂, e.g., an electrically conductive material, such as copper, aluminum, or the like, passing through substrate 101 interconnect electronic components 102 and 104. Specifically, via 110₁ interconnects a contact point 114₁ of electronic component 102, e.g., a solder ball, pad, pin, or the like, to a contact point 116₁ of electronic component 104. Further, via 110₂ interconnects a contact point 114₂ of electronic component 102, e.g., a solder ball, pad, pin, or the like, to a contact point 116₂ of electronic component 104. Conductive planes 122₁ to 122_N are disposed within substrate 101. In one embodiment, conductive planes 122₁ to 122_N are substantially parallel to each other. In another embodiment, via 110₁ is connected to conductive plane 122_N. In other embodiments, via 110₂ is connected to conductive plane 122₁. In some embodiments, conductive planes 122₁ to 122_N are ground planes, power planes, interconnect planes, or the like and are of copper, aluminum, or the like.

[0017] Figures 2 and 3 illustrate connection of vias 110 to conductive planes 122 according to an embodiment of the present invention. Figure 2 is a perspective view and Figure 3 is a top view of Figure 2. In one embodiment, via 110 is an electrically conductive coating of a hole passing through a substrate and thus is a hollow cylinder, as shown in Figures 2 and 3.

10018] Via 110 passes through an aperture 215 passing through conductive plane 122 to form a gap 230 between a surface 240 of via 110 and a surface 216 of conductive plane 122 corresponding to a perimeter 218 of aperture 215. In one embodiment, gap 230 is annular, as shown in Figures 2 and 3. Each of tabs 220₁ to 220_M of conductive plane 122 radiate inwardly from perimeter 218 of aperture 215 and span gap 230. Each of tabs 220₁ to 220_M of conductive plane 122 respectively contact via 110 at locations 222₁ to 222_M to electrically connect conductive plane 122 to via 110. In one embodiment, each of tabs 220₁ to 220_M is integral with conductive plane 122. In another embodiment, each of tabs 220₁ to 220_M lies substantially in a plane of conductive plane 122. Gap 230 provides an uninterrupted path for a portion of a high-frequency current flowing substantially on surface 240 of via 110 to flow between each of tabs 220₁ to 220_M, through gap 230, and past conductive plane 122, as depicted by arrows 250 and 252. Therefore, this portion of the high-frequency current does not change its course as occurs in conventional situations where there is no gap between the via and the conductive plane.

10019] In operation, as depicted in Figure 1, high-frequency current flows from connection 114₁ substantially on surface 240₁ of via 110₁ to the location where via 110₁ is connected to conductive plane 122_N, as depicted by arrow 130. As discussed above, gap 230 provides an uninterrupted path for a portion of the high-frequency current to flow as shown by arrow 250 in Figure 1. This portion of the high-frequency current does not alter its course upon encountering the location where via 110₁ is connected to conductive plane 122_N to flow on the surface of conductive plane 122_N as would occur in conventional situations where there is no gap between the via and the conductive plane. Therefore, the inductance and thus the impedance for the high-frequency current is lower and it results in lower noise voltage than for conventional situations where the high-frequency current changes its course to flow around the conductive plane.

10020] The high-frequency current continues to flow substantially on surface 240₁ of via 110₁ to connection 116₁ of electronic component 106, as shown by arrow 133. The high-frequency current flows through electronic component 106 from connection

116₁ to connection 116₂. Then, the high-frequency current flows substantially on surface 240₂ of via 110₂ from connection 116₂ to the location where via 110₂ is connected to conductive plane 122₁, as shown by arrow 134. As discussed above, gap 230 provides an uninterrupted path for a portion of the high-frequency current to flow as shown by arrow 252 in Figure 1. This portion of the high-frequency current does not alter its course upon encountering the location where via 110₂ is connected to conductive plane 122₁ to flow on the surface of conductive plane 122₁ as would occur in conventional situations where there is no gap between the via and the conductive plane. Therefore, the inductance and thus the impedance for the high-frequency current is lower and it results in lower noise voltage than for conventional situations where the high-frequency current changes its course to flow around the conductive plane. The high-frequency current then continues to flow substantially on surface 240₂ of via 110₂ to connection 114₂, as indicated by arrow 136.

[0021] Figure 4 illustrates a via 400 passing through each of conductive planes 405₁ to 405_P according to another embodiment of the present invention. In one embodiment, via 400 and each of conductive planes 405₁ to 405_P are disposed in a substrate, such as substrate 101 of Figure 1. In various embodiments, each of conductive planes 405₁ to 405_P is a ground plane, power plane, interconnect plane, or the like and is of copper, aluminum, or the like. In one embodiment, via 400 interconnects electronic components, such as electronic components 102 and 104 of Figure 1, respectively disposed on opposite sides of a substrate. In another embodiment, via 400 is as described for via 110 of Figures 2 and 3.

[0022] In other embodiments, via 400 is connected to each of conductive planes 405₁ to 405_P as described above for via 110 and conductive plane 122 of Figures 2 and 3 so that gaps 430₁ to 430_P respectively separate a surface 440 of via 400 from conductive planes 405₁ to 405_P and each of tabs 420_{1,1} through 420_{Q,1} to tabs 420_{1,P} through 420_{R,P}, respectively of each of conductive planes 405₁ to 405_P, respectively span each of gaps 430₁ to 430_P to electrically connect each of conductive planes 405₁ to 405_P to via 400.

[0023] At least a portion of each of gaps 430₁ to 430_P is aligned with a portion of another of each of gaps 430₁ to 430_P. For example, in one embodiment, a portion of gap 430₁ that lies between successively adjacent tabs of tabs 420_{1,1} through 420_{Q,1} of conductive plane 405₁ aligns with a portion of gap 430_P that lies between successively adjacent tabs of tabs 420_{1,P} through 420_{R,P} of conductive plane 405_P. This provides an uninterrupted path for a portion of a high-frequency current flowing substantially on surface 440 of via 400 to flow between each of tabs 420_{1,1} through 420_{Q,1}, through gap 430₁, between each of tabs 420_{1,P} through 420_{R,P}, and through gap 430_P or vice versa, as shown by arrows 450 and 452 in Figure 4.

[0024] To manufacture an electronic circuit board according to an embodiment of the present invention, conductive planes 122 are formed within substrate 101. Vias 110 are also formed in substrate 101 so that they respectively pass through and make contact with conductive planes 122, as illustrated in Figures 1-3. In one embodiment, via 400 is formed in a substrate, such as substrate 101, and passes through and makes contact with each of conductive planes 405₁ to 405_P, as illustrated in Figure 4.

[0025] A gap 230 is formed between surface 240 of via 110 and conductive plane 122 to provide an uninterrupted path for current flowing substantially on surface 240. In one embodiment, forming gap 230 includes forming tabs 220₁ to 220_M that span gap 230 and contact surface 240, as shown in Figures 2 and 3. In another embodiment, each of gaps 430₁ to 430_P is respectively formed between each of conductive planes 405₁ to 405_P and surface 440 of via 400, and a portion of each of gaps 430₁ to 430_P is aligned with a portion of another of each of gaps 430₁ to 430_P, as shown in Figure 4. In some embodiments, forming each of gaps 430₁ to 430_P includes respectively forming each of tabs 420_{1,1} through 420_{Q,1} to tabs 420_{1,P} through 420_{R,P}, as shown in Figure 4.

Conclusion

[0026] Embodiments of the present invention have been described. The embodiments provide for a high-frequency current flowing substantially on a surface of a via to flow through a gap separating the via from a conductive plane through which the via passes. This reduces inductance and thus impedance and noise as compared to

when a high-frequency current flowing substantially on a surface of a via changes its course and flows substantially on a surface of a conductive plane to flow around the plane.

[0027] Although specific embodiments have been illustrated and described in this specification, it will be appreciated by those of ordinary skill in the art that any arrangement that is calculated to achieve the same purpose may be substituted for the specific embodiment shown. This application is intended to cover any adaptations or variations of the present invention. For example, via 110 of Figures 2 and 3 and via 400 of Figure 4 can be a solid rather than hollow. Embodiments of the present invention are not limited by substrates, such as 101, having two vias, such as 110₁ and 110₂, as shown in Figure 1. Rather any number of vias 110 may be disposed within substrate 101, and these vias may be electrically connected to any number of conductive planes, e.g., conductive planes 122₁ to 122_N disposed within the substrate. Moreover, these vias may interconnect any number of electronic components disposed on opposite sides of the substrate. It is manifestly intended that this invention be limited only by the following claims and equivalents thereof.